

# Optical band gap of the $\alpha$ -mercuric iodide

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(Received 8 May 1995; accepted for publication 29 June 1995)

We investigate by photoacoustic spectroscopy the optical band-gap energy of mercuric iodide,  $\alpha$ -HgI<sub>2</sub>, grown by sublimation in a sealed ampoule. Due to its importance as a detector material operating at ambient temperature, the physical properties of  $\alpha$ -HgI<sub>2</sub> have been recently studied. We found, by two different methods, the band-gap energies  $E_G=2.32$  and 2.39 eV, respectively. These results are in good agreement with recent measurements based on reflection and absorption spectra. © 1995 American Institute of Physics.

Since 1982, when the researches on mercuric iodide celebrated the tenth anniversary of the first article related to its use as a room-temperature detector,<sup>1,2</sup> much attention has been paid to investigation of this semiconductor toward optical properties and development of crystal growth and device fabrication techniques. The mercuric iodide crystal is a wide-band-gap semiconductor.<sup>3,4</sup> The band-gap energy has been measured by different methods, varying from  $E_G=2.11$  to 2.397 eV.<sup>4-7</sup> Recently Burger and Nason<sup>4</sup> measured  $E_G$  by a method based on reflection and absorption spectra. They found  $E_G=2.292$  eV at room temperature. This result differs from other experiments.<sup>4-7</sup> In the absence of a complete study in a  $\alpha$ -HgI<sub>2</sub>, further analysis of this system is of much interest.

As the value of  $E_G$  is an important parameter in electronic and optoelectronic design, we investigate the optical absorption at the fundamental band edge by the photoacoustic spectroscopy (PAS) technique. PAS has been proved to be a simple and reliable nondestructive method for measuring the optical properties of solids or powder samples.<sup>8-11</sup> It has the advantage of obtaining directly the spectra of the heat generated in a sample, due to nonradiative deexcitation process, following the absorption of light, on any type of materials.<sup>8-14</sup>

In order to obtain a high-purity mercuric iodide, we have used the following procedure: iodine and mercury elements from Merck (5N) were placed in a Pyrex ampoule (18 cm length and 15 mm diameter) with a ratio obeying the stoichiometry of  $\alpha$ -HgI<sub>2</sub>, resulting in a total mass of 15 g. The ampoule was closed under vacuum. This sealed ampoule was submitted to a temperature of 200 °C during 24 h to obtain a homogeneous material. After this, the sealed ampoule with

the material filling its superior part was positioned in a vertical furnace under a thermal gradient from 150 to 100 °C, during 7 days. The recrystallized compound filled the inferior part of sealed ampoule through a sublimation process. With this method, we obtained polycrystalline  $\alpha$ -HgI<sub>2</sub> of very good optical quality. The sample used in this work is a platelet of this grown material with 1 mm thickness.

The PAS system consists of a tungsten lamp source of 200 W, a monochromator, a chopper with a modulation frequency of 17 Hz, photoacoustic cells, a lock-in amplifier, and a computer. The wavelength range is 300–850 nm. The resultant PA spectra are monitored by the computer, which simultaneously displays the wavelength-dependent signal intensity.

The optical band-gap energy has been estimated from the absorption data obtained as a function of the wavelength.

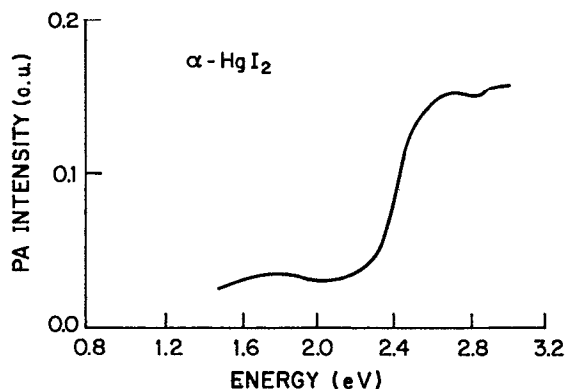


FIG. 1. Room-temperature PA spectra of  $\alpha$ -HgI<sub>2</sub> as a function of photon energy.

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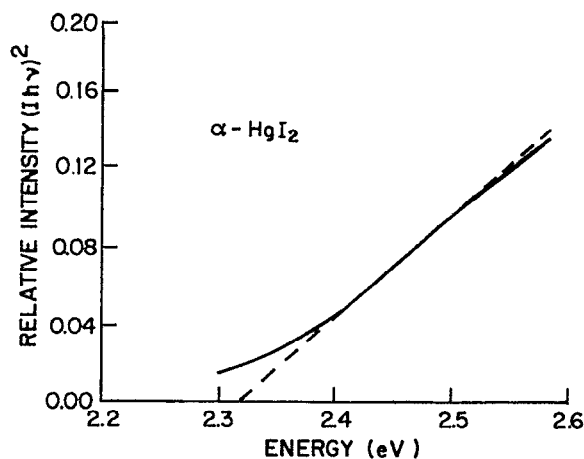


FIG. 2. Relative intensity  $(Ih\nu)^2$  vs photon energy near the fundamental absorption edge at room temperature. The dashed line crosses the energy axis at 2.32 eV.

We use the relation

$$Ih\nu = A(h\nu - E_G)^{1/2}, \quad (1)$$

which is valid for allowed direct transition.<sup>15</sup> In Eq. (1),  $I$  is the absorption intensity and  $A$  a coefficient. From the data obtained, a straight-line fitting of  $(Ih\nu)^2$  versus the photon energy  $h\nu$  and the change in the relative intensity of the absorption confirm that when the linear portion of the plot crosses the  $h\nu$  axis, we find the energy gap  $E_G = 2.32$  eV. We also calculate  $E_G$  by the changing of the derivative in the fundamental absorption edge and found  $E_G = 2.39$  eV. Both

values are closer to Burger and Nason's<sup>4</sup> results, i.e.,  $E_G = 2.292$  eV, than others recorded in the literature.<sup>4-7</sup>

In Fig. 1 we show the PA spectra for  $\alpha$ -HgI<sub>2</sub>, at room temperature, as a function of photon energy. Figure 2 shows the relation  $(Ih\nu)^2$ , here denominated as PA intensity, as a function of the photon energy.

In summary we have shown that the PAS technique provides a reliable method to determine room-temperature value of the fundamental band-gap energy  $E_G$  of  $\alpha$ -HgI<sub>2</sub>. The value of  $E_G$  is similar to the one obtained recently by a method based on reflection and absorption spectra.<sup>4</sup>

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